

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the application of:

Tomohiro MIYASHITA

Appln. No.:

Filed: HERewith

For: MICROSCOPE OPTICAL SYSTEM AND MICROSCOPE OBJECTIVE
LENS

* * *

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Pursuant to 37 C.F.R. § 1.56, and without any
assertion as to materiality or prior art effect, the
documents listed on the attached Form PTO-1449 are hereby
cited.

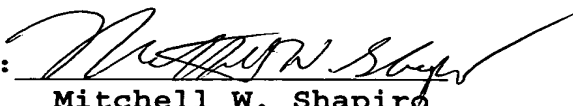
Documents AK and AL on the attached List were cited in
the specification, on page 3, and their relevance is
indicated therein.

Respectfully submitted,

MWS:sjk

Miles & Stockbridge P.C.
1751 Pinnacle Drive
Suite 500
McLean, Virginia 22102-3833
(703) 903-9000

By:


Mitchell W. Shapiro
Reg. No. 31,568

November 26, 2003

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|---|----|------------------------|-----------------|---|--------------|-------------------|--------------------|
| FORM PTO-1449 | | | | Atty. Docket No. XA-9999 | | Appln. No. | |
| <u>LIST OF DOCUMENTS CITED BY APPLICANT</u> | | | | | | | |
| | | | | Applicant Tomohiro MIYASHITA | | | |
| | | | | Filing Date HEREWITH | | Group | |
| U.S. PATENT DOCUMENTS | | | | | | | |
| Examiner Initial | | Document Number | Date | Name | Class | Sub-class | Filing Date |
| | AA | 6,320,702 | 11/20/01 | Yonezawa | 359 | 686 | |
| | AB | | | | | | |
| | AC | | | | | | |
| | AD | | | | | | |
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| | AH | | | | | | |
| | AI | | | | | | |
| FOREIGN PATENT DOCUMENTS | | | | | | | |
| Examiner Initial | | Document Number | Date | Country | Class | Sub-class | Translation |
| | AJ | 2000-171721 | 06/23/00 | Japan (Abstract Only) | | | Abstract |
| | AK | 2001-166215 | 06/22/01 | Japan (Abstract Only) | | | Abstract |
| | AL | 09-033818 | 02/07/97 | Japan (Abstract Only) | | | Abstract |
| | AM | | | | | | |
| | AN | | | | | | |
| | AO | | | | | | |
| OTHER (including author, title, date, pertinent pages, etc.) | | | | | | | |
| | AP | | | | | | |
| | AQ | | | | | | |
| | AR | | | | | | |
| Examiner | | | | Date Considered | | | |
| EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant. | | | | | | | |